

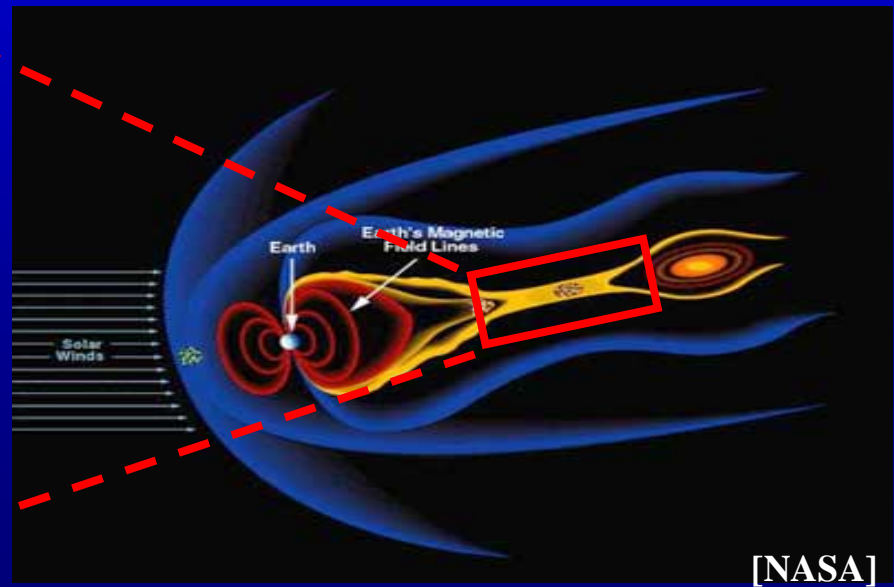
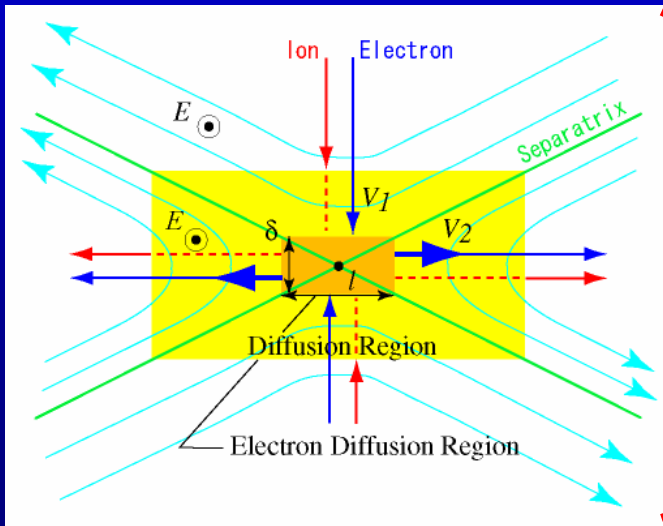
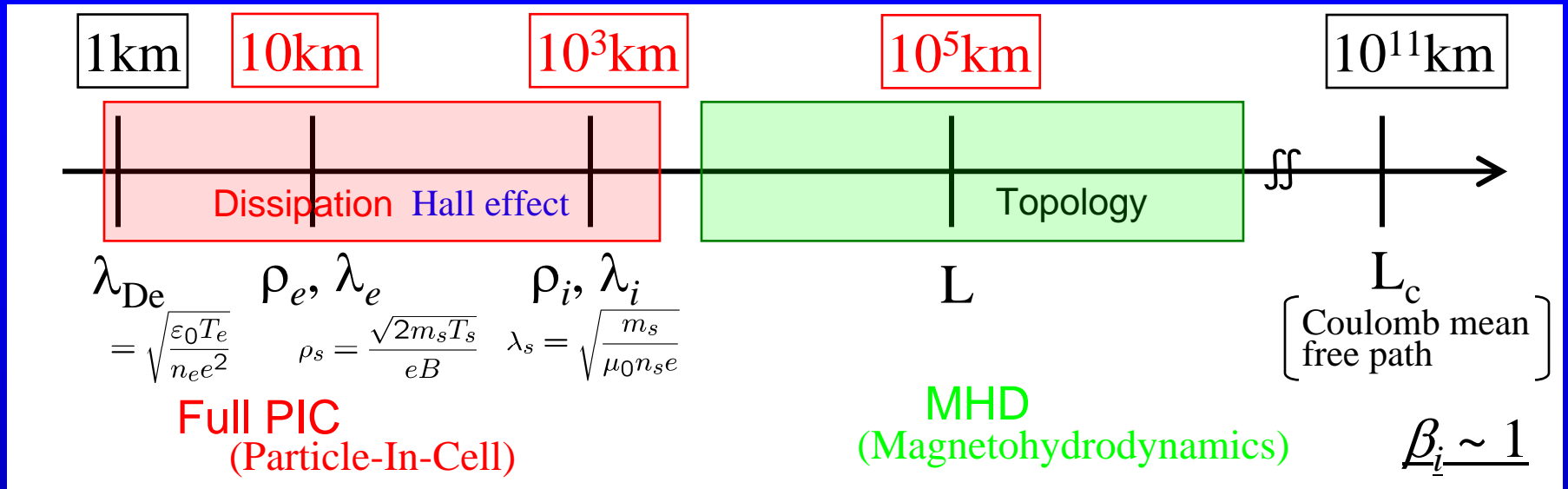
# 高速磁気リコネクションにおける プラズモイド誘導乱流

藤本桂三

国立天文台理論研究部

*In collaboration with* Richard Sydora (Univ Alberta)

# Multi-Scale Nature of Reconnection



[NASA]

# Impact of Dissipation Mechanism

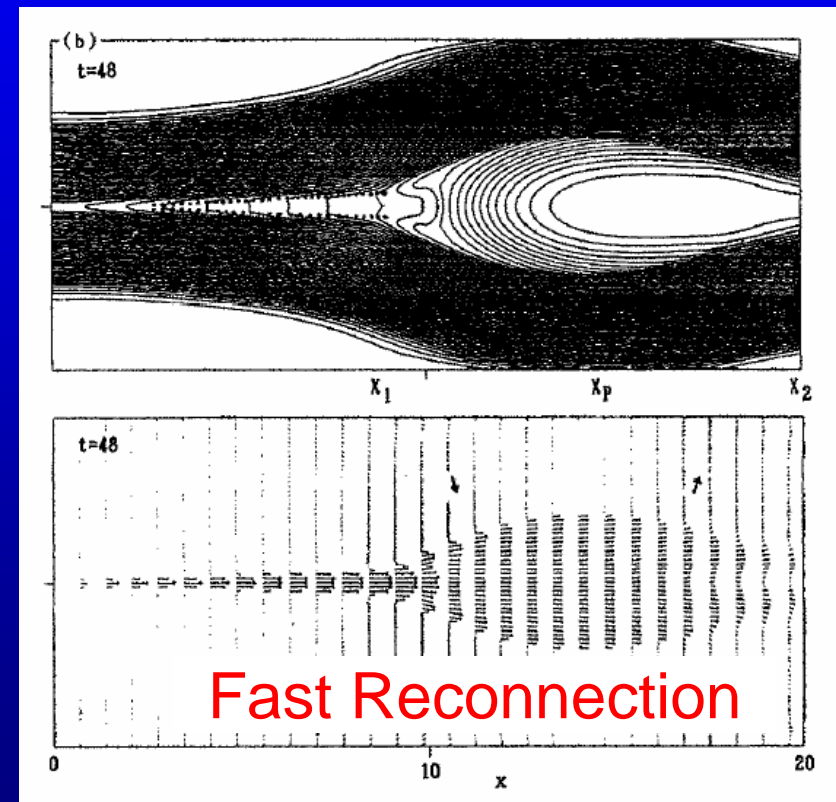
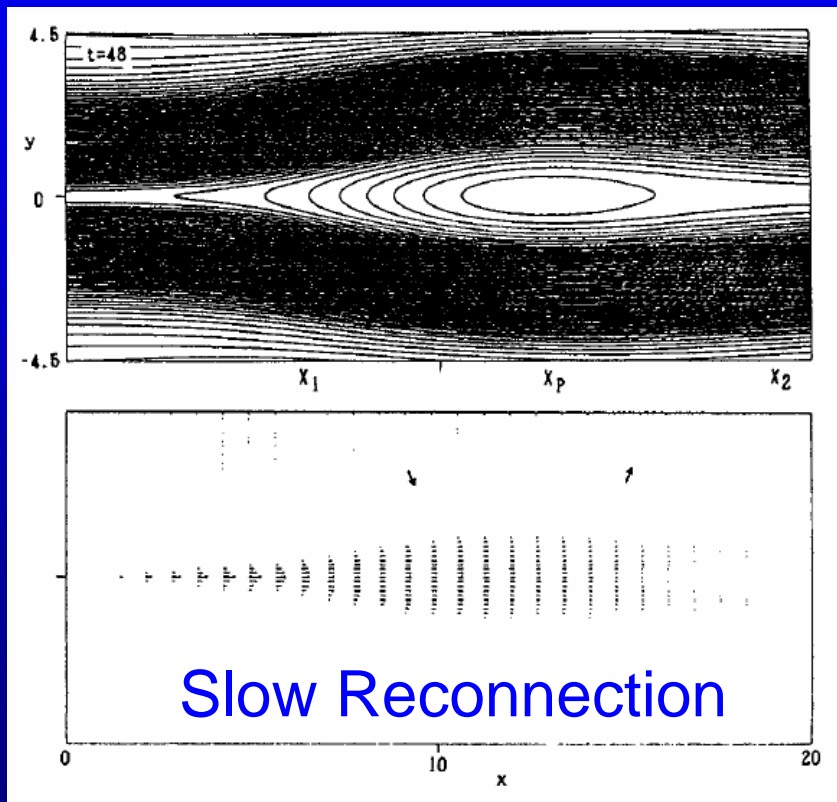
Ugai, PoP, 1995

MHD simulations

$$\frac{\partial B}{\partial t} = \eta \nabla^2 B / \mu_0$$

Uniform  $\eta$

Localized  $\eta$

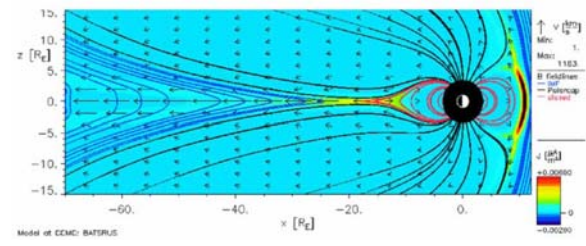


$$\frac{\partial B}{\partial t} = \eta \nabla^2 B / \mu_0$$

Numerical resistivity only

Nongyrotropic correction case

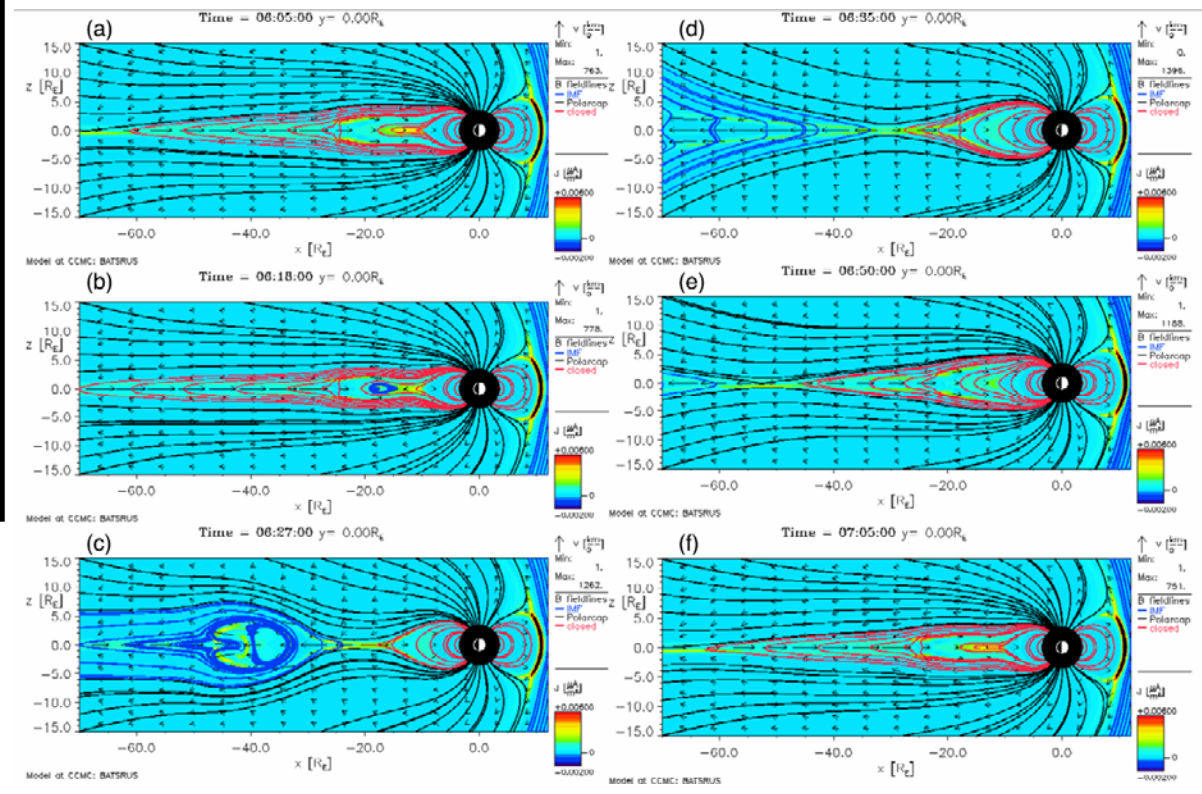
$$E^{ng} = \frac{1}{ne} \left( \frac{\partial P_{ixy}}{\partial x} + \frac{\partial P_{ixz}}{\partial z} \right) = \frac{m_i}{e} \sqrt{\frac{2P}{\rho}} \frac{\partial V_x}{\partial x}$$



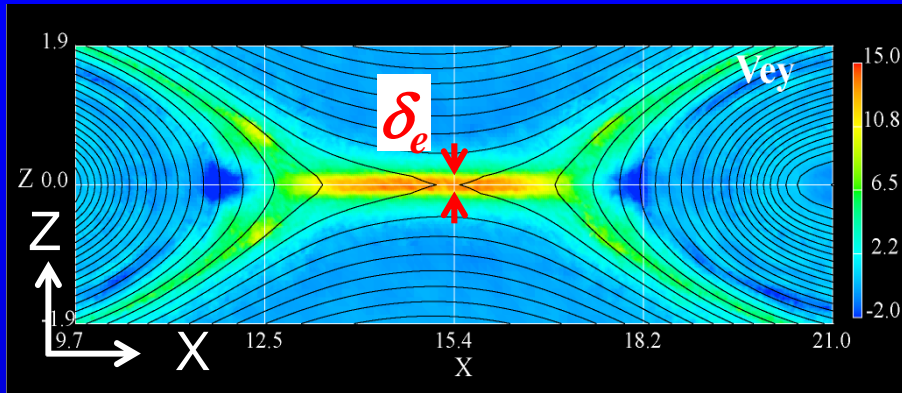
- Slow reconnection
- Quasi-steady configuration

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- Fast reconnection
- Quasi-periodic process



# Dissipation in 2D Kinetic Reconnection

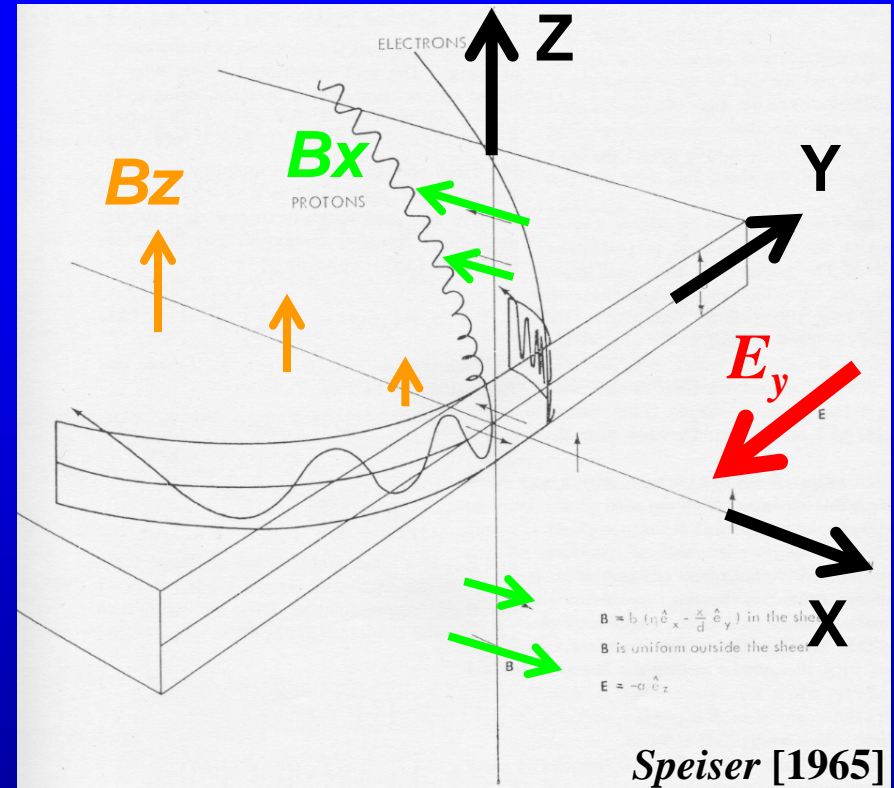


PIC simulations

$$-E_y \approx \frac{1}{ne} (\nabla \cdot \mathbf{P}_e)_y \quad \text{at x-line}$$

Electron viscosity

[Cai & Lee, 1997; Hesse et al., 1999]



$$\frac{1}{nee} \nabla \cdot \mathbf{P}_e \approx E_y \left[ 1 - \frac{5}{2} \left( \frac{z}{\delta_e} \right)^2 \right] = E_y$$

Fluid

Particle

[Fujimoto & Sydora, PoP, 2009]

Inertia resistivity

$$\eta_{in} = \frac{m_e}{ne e^2} \frac{1}{\tau_{tr}}$$

$\tau_{tr}$ : Transit time through the diffusion region



# Inertia Resistivity & Current Sheet Width

## X-line

$$E_{y,xline} = \eta_{in} j_y$$

$$\eta_{in} = \frac{m_e}{n_e e^2} \frac{1}{\tau_{tr}} \approx \frac{m_e}{n_e e^2} \frac{V_{inflow}}{\delta_e}$$

$$j_y \approx -\frac{1}{\mu_0} \frac{B_{inflow}}{\delta_e}$$

## Inflow region

$$E_{y,inflow}$$

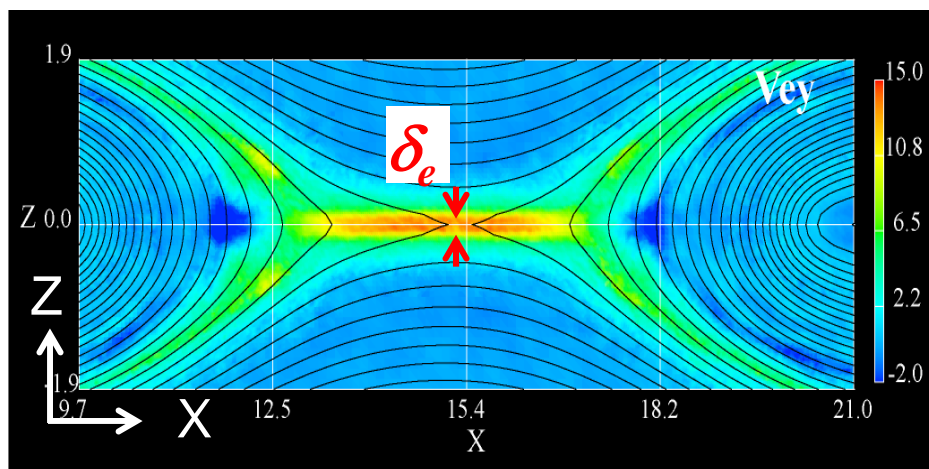
$$= -V_{inflow} B_{inflow}$$

$$\underline{E_{y,xline} = E_{y,inflow}}$$

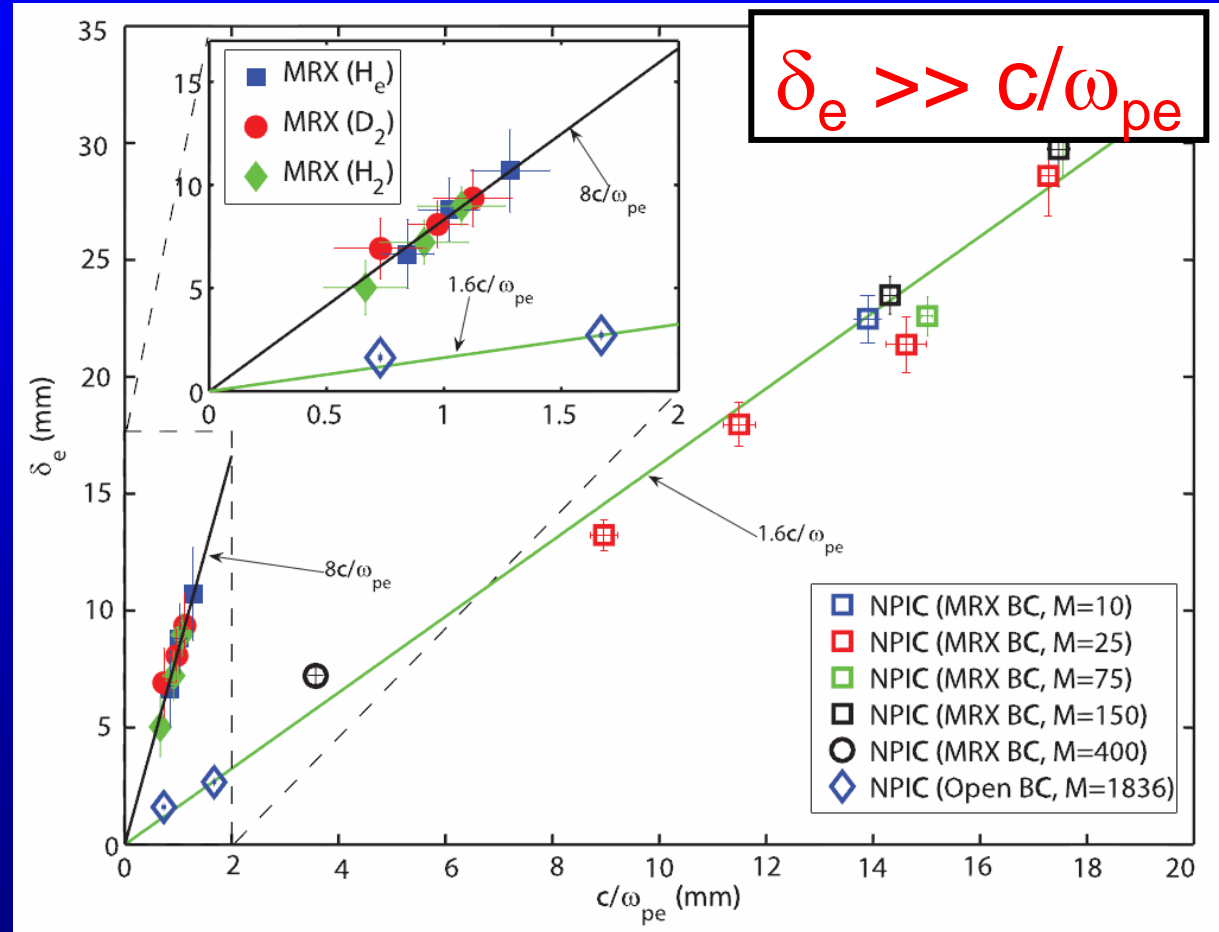
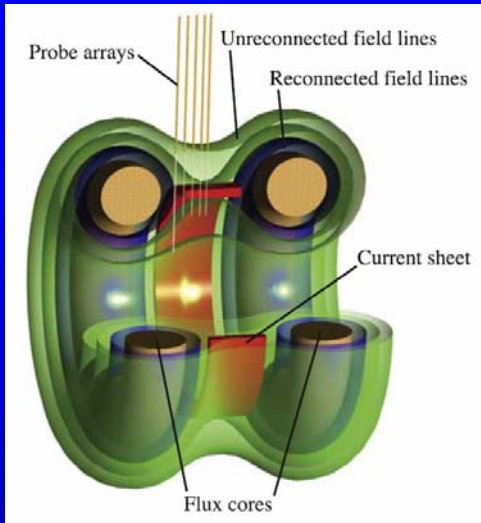


$$\delta_e \approx \frac{c}{\omega_{pe}} = \lambda_e$$

Very thin current layer!



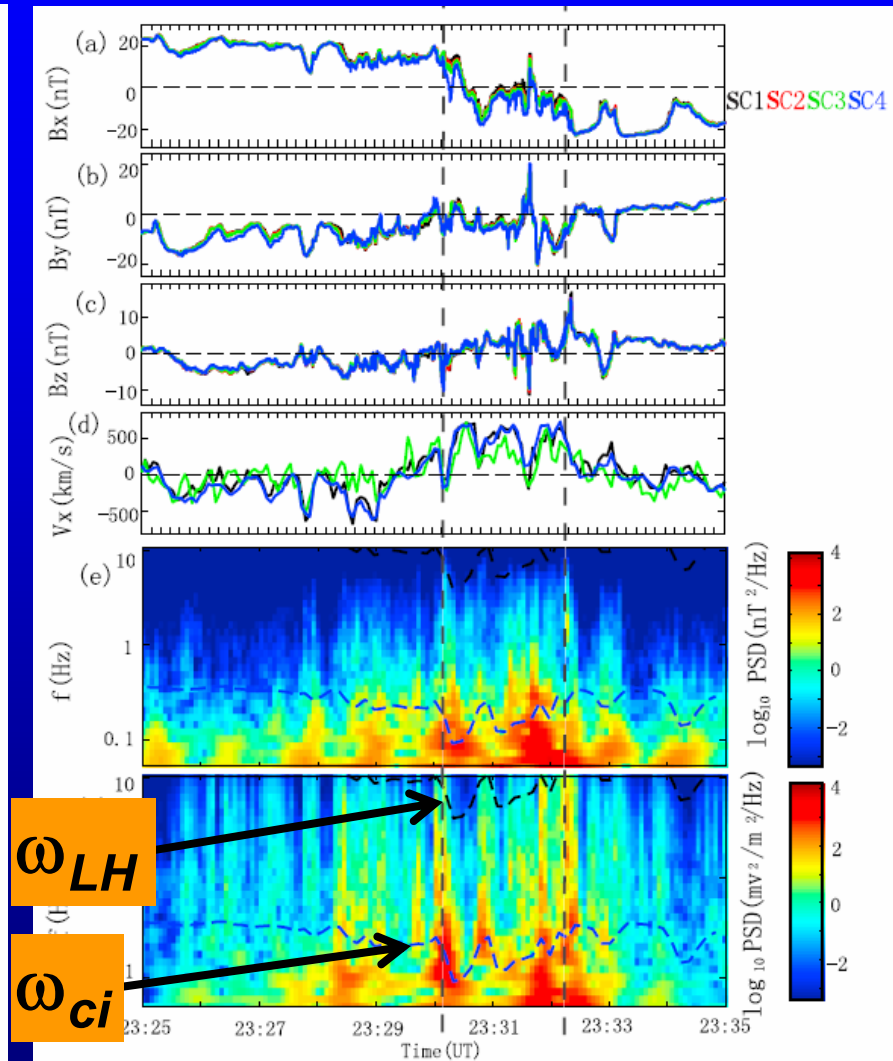
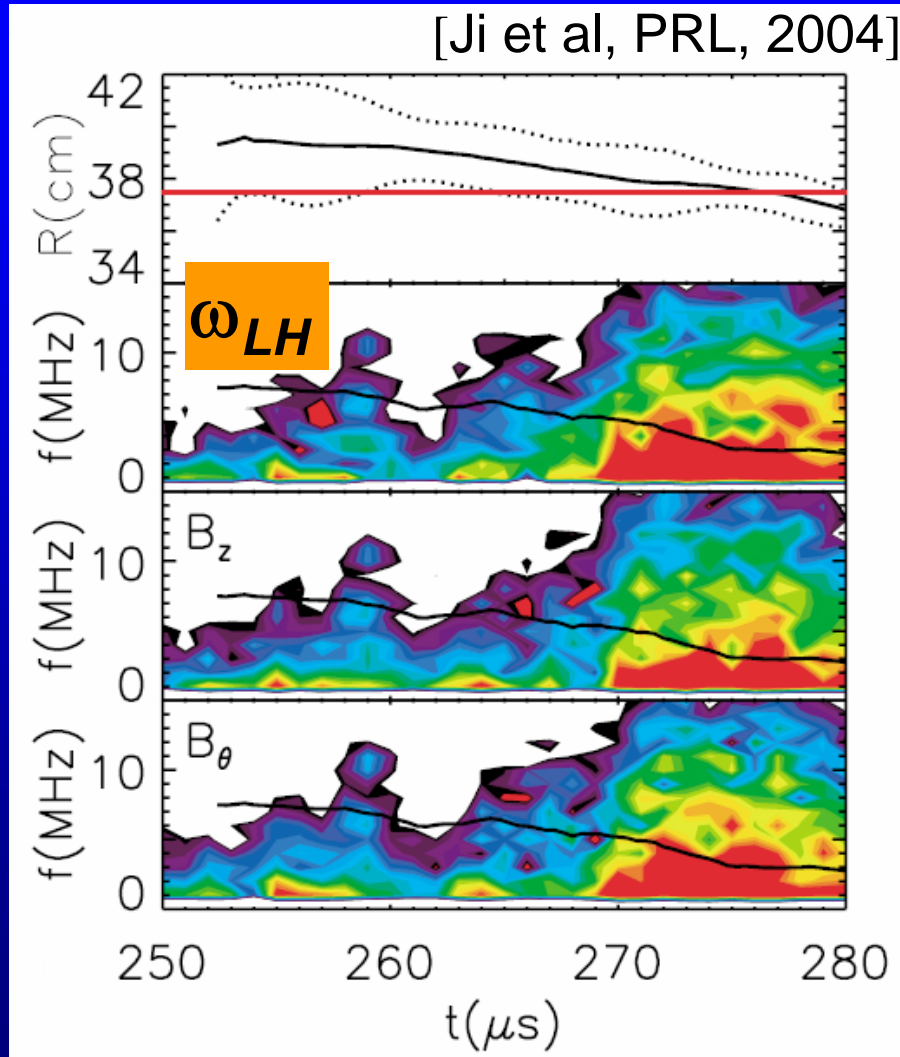
# Implication of Anomalous Effects: Lab. Experiment



[Ji et al., GRL, 2008]

# Implication of Anomalous Effects: Wave Activities

[Zhou et al, JGR, 2009]





# Implication of Anomalous Effects

## X-line

$$E_{y,xline} = (\eta_{in} + \eta) j_y$$

$$\eta_{in} = \frac{m_e}{n_e e^2} \frac{1}{\tau_{tr}} \approx \frac{m_e}{n_e e^2} \frac{V_{inflow}}{\delta_e}$$

$$j_y \approx -\frac{1}{\mu_0} \frac{B_{inflow}}{\delta_e}$$

## Inflow region

$$E_{y,inflow}$$

$$= -V_{inflow} B_{inflow}$$

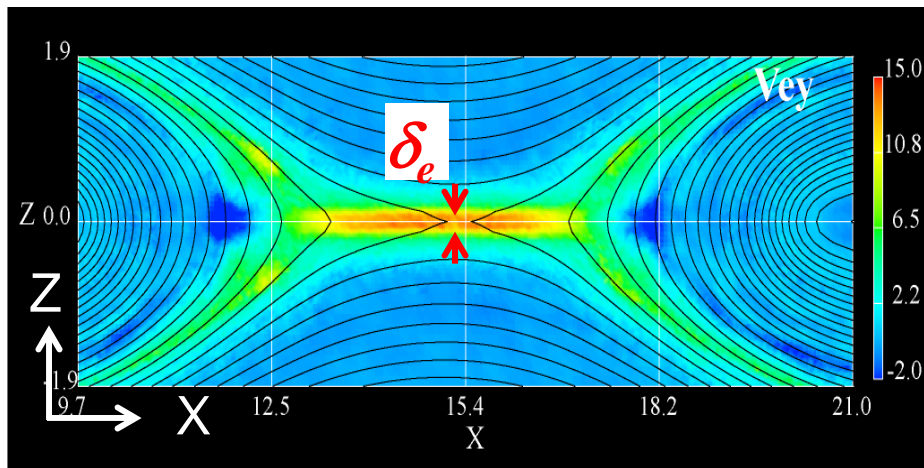
$$\underline{E_{y,xline} = E_{y,inflow}}$$



$$\delta_e \approx \frac{\lambda}{2} + \sqrt{\left(\frac{\lambda}{2}\right)^2 + \lambda_e^2}$$

$$> \lambda_e = c/\omega_{pe}$$

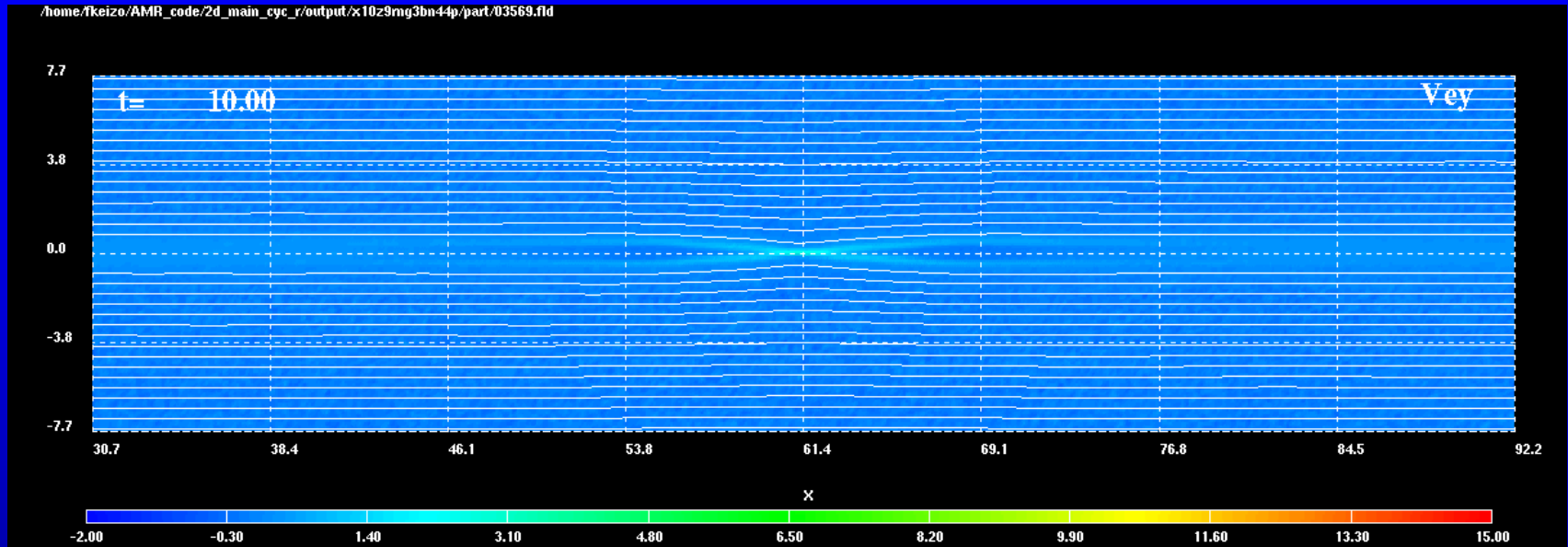
$$\lambda \equiv \eta/\mu_0 V_{inflow}$$



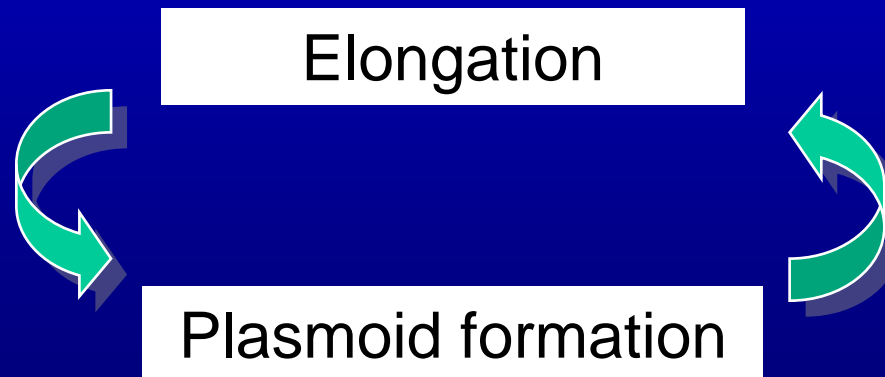
# Dynamical Current Sheet

[Fujimoto, PoP, 2006;  
Daughton et al., PoP, 2006]

## 2D PIC simulation



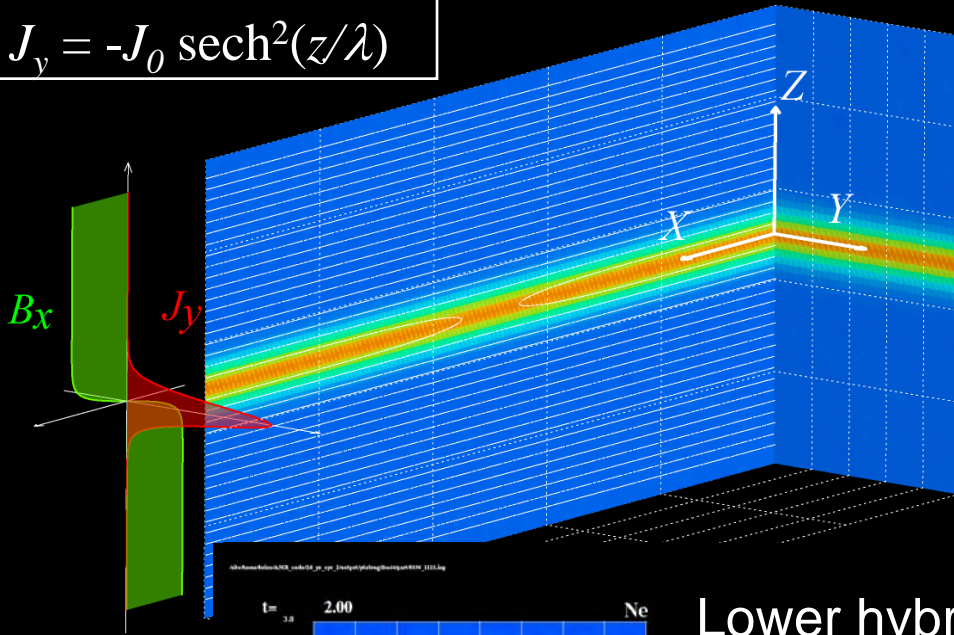
Thin current layer:



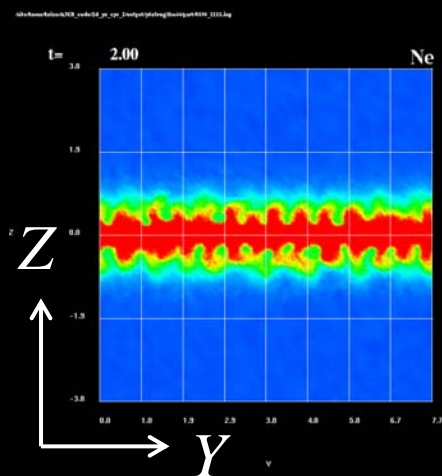
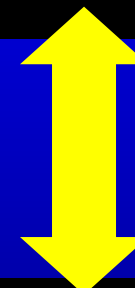
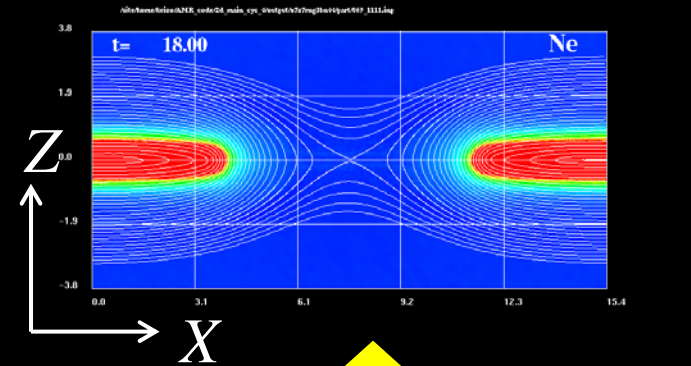
# Instabilities in the Harris Current Sheet

$$B_x = -B_0 \tanh(z/\lambda)$$

$$J_y = -J_0 \operatorname{sech}^2(z/\lambda)$$



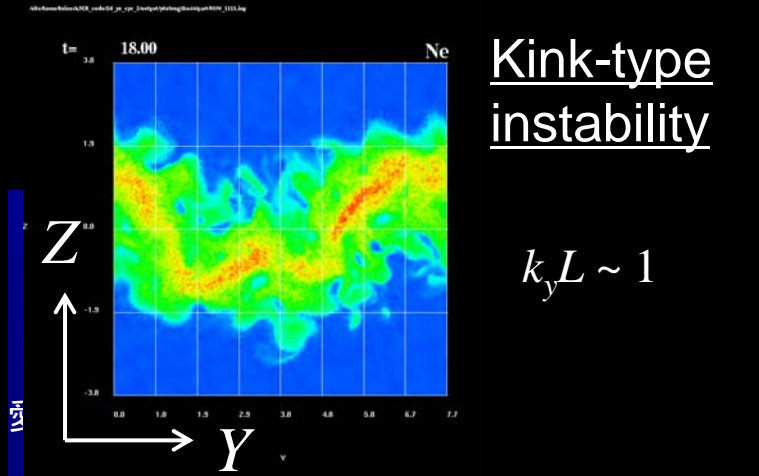
## Tearing instability



Lower hybrid drift instability (LHDI)

$$k_y r_{Le} \sim 1$$

$$\gamma \sim \omega_{lh}$$

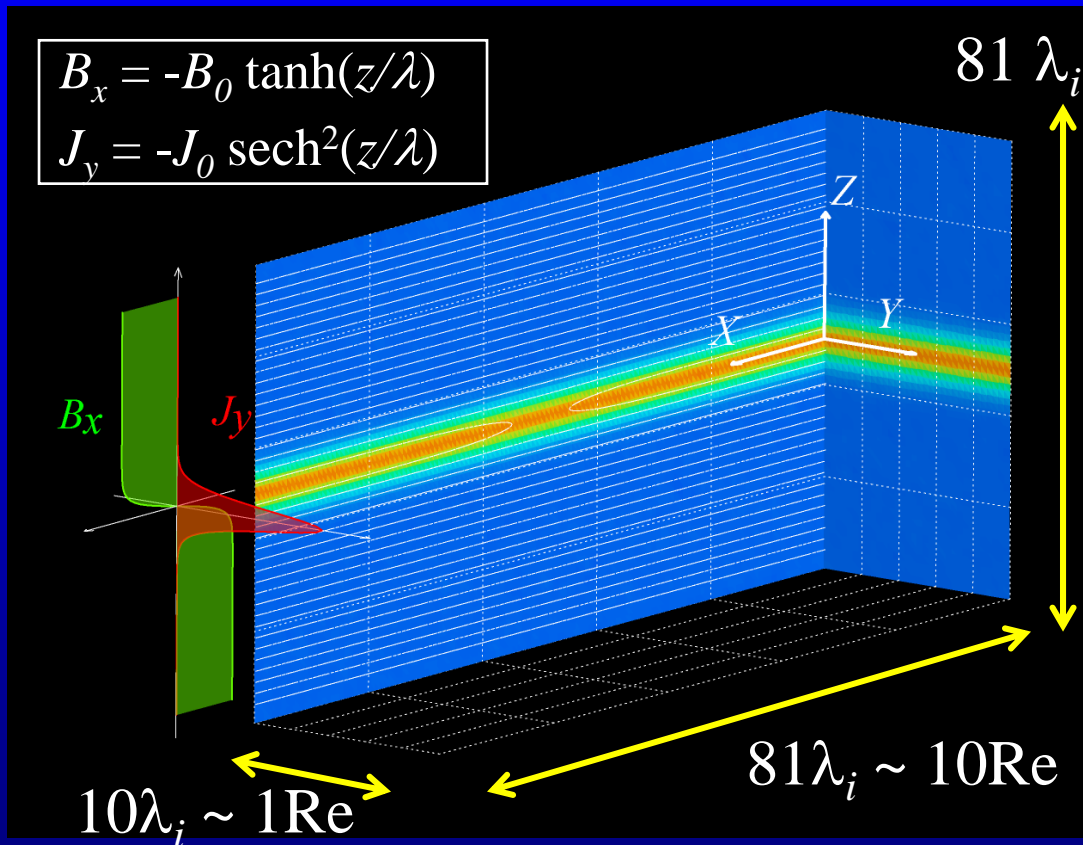


Kink-type instability

$$k_y L \sim 1$$

# Simulation Setup

AMR-PIC-3D code [Fujimoto, JCP, 2011]  
on Fujitsu FX1 (1024 cores)



$m_i/m_e = 100$

Max resolution:

$4096 \times 512 \times 4096 \sim 10^{10}$

Max number of particles

Ion + Electron  $\sim 10^{11}$

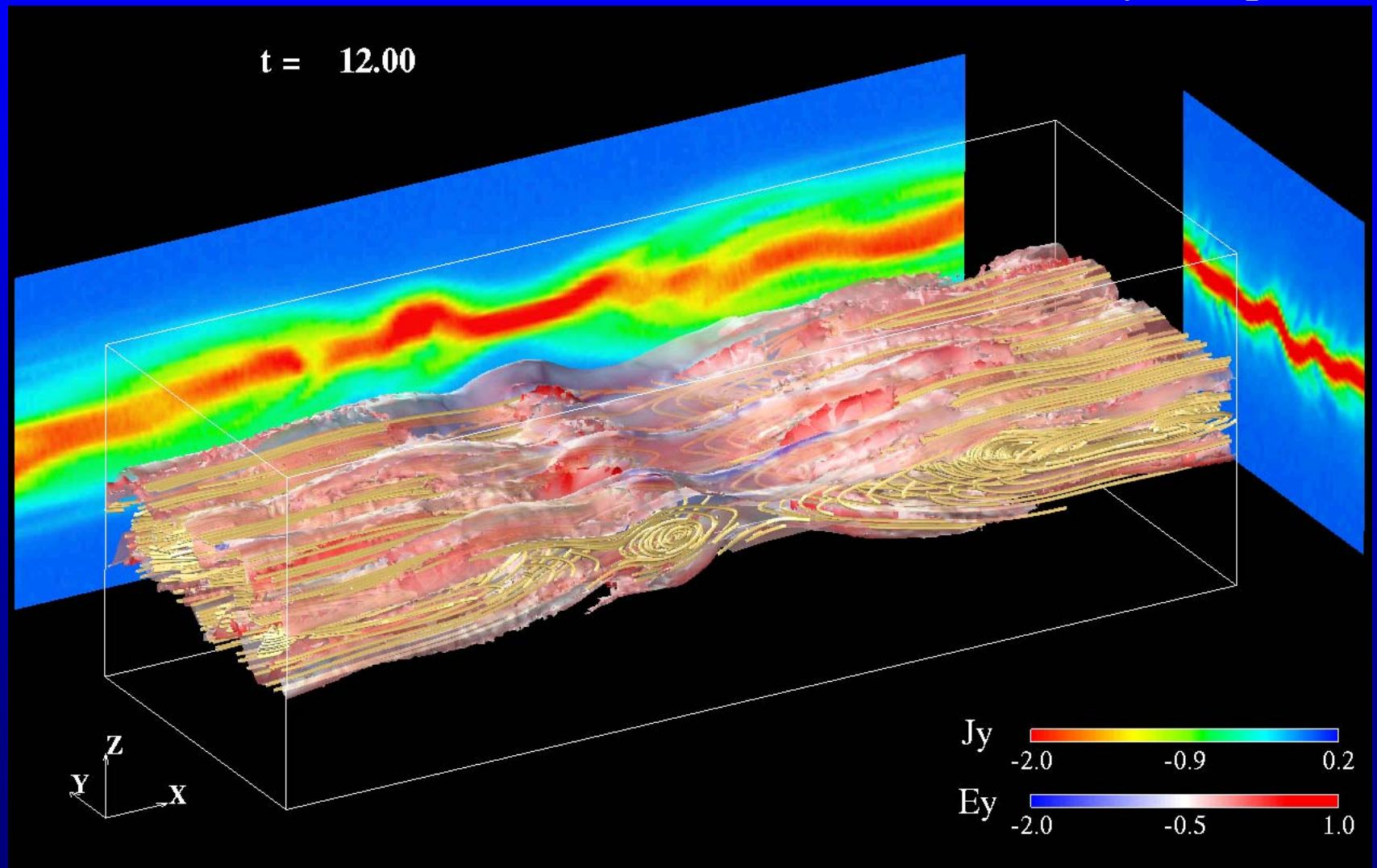
Max memory used  $\sim 6\text{TB}$



# Time Evolution of the Current Sheet

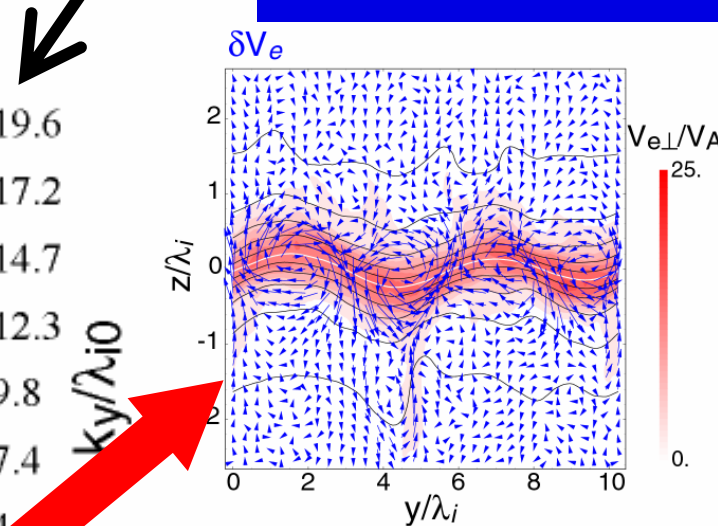
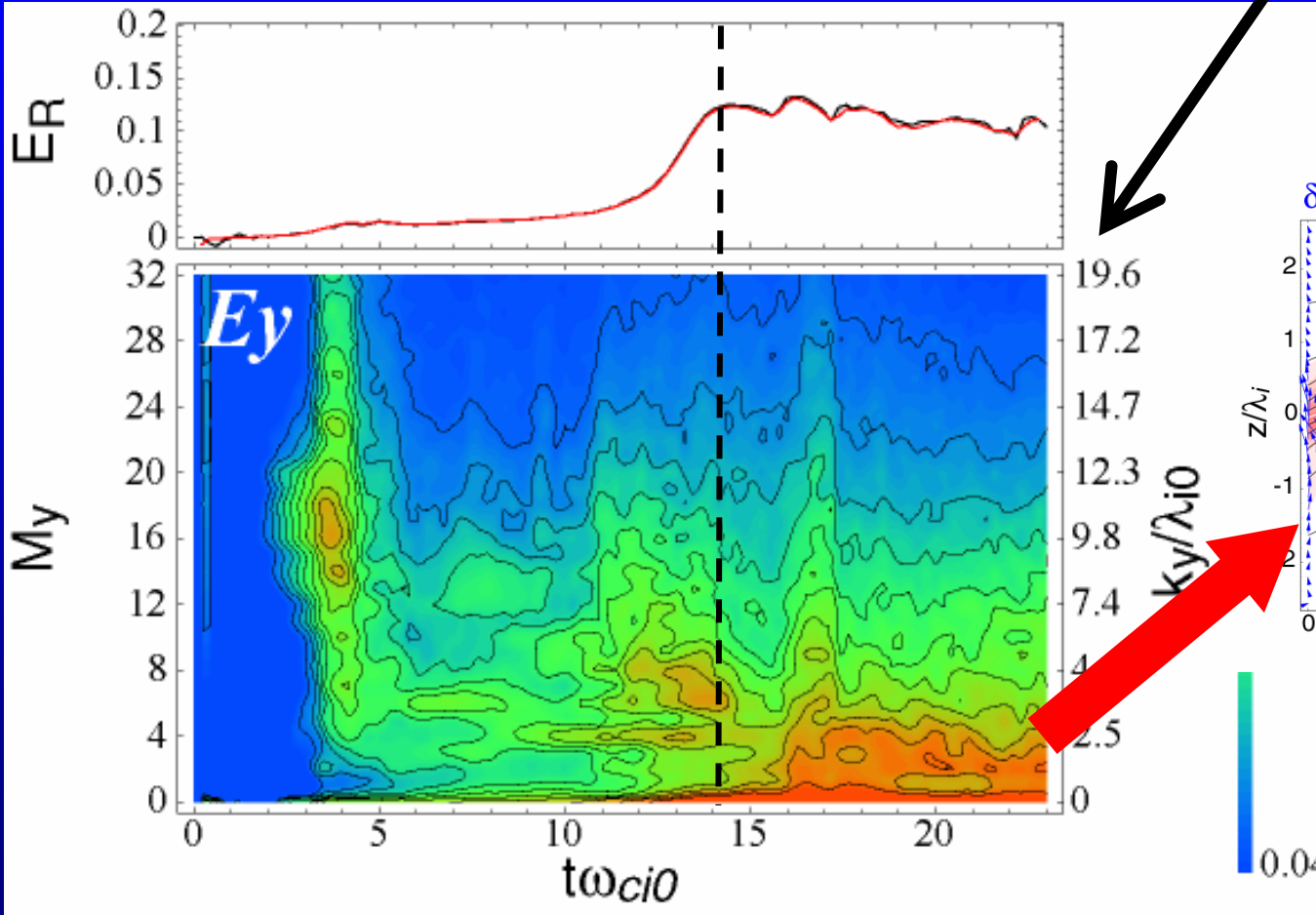
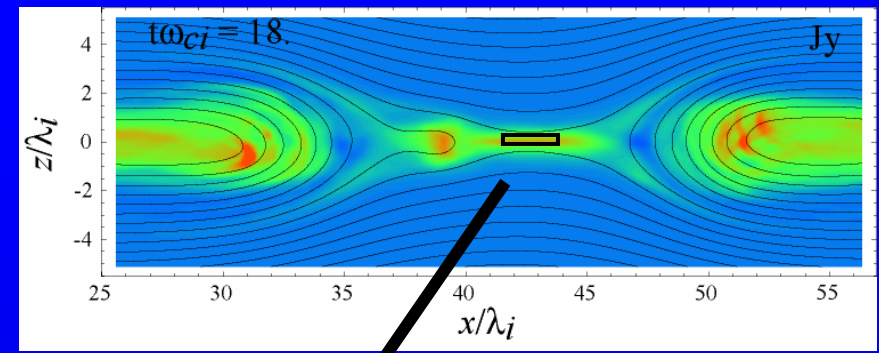
Surface:  $|J|$ , Line: Field line

Color on the surface:  $E_y$ , Cut plane:  $J_y$





# Wave Activity



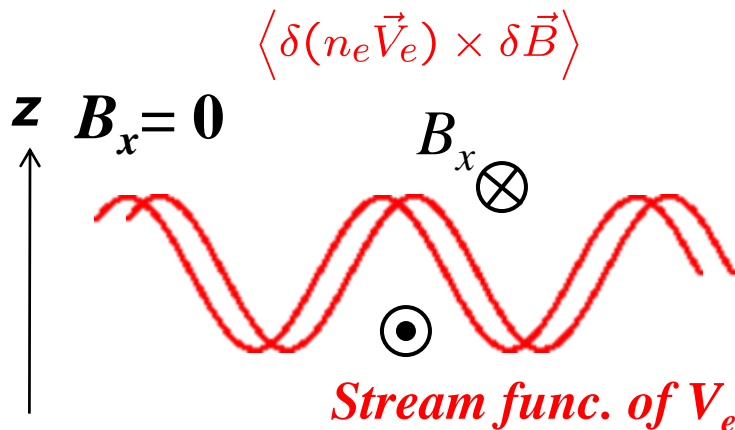
# Wave-Particle Interactions

$$A = \langle A \rangle + \delta A \quad \left( \langle \cdot \rangle = \frac{1}{L_y} \int_0^{L_y} \cdot dy \right)$$

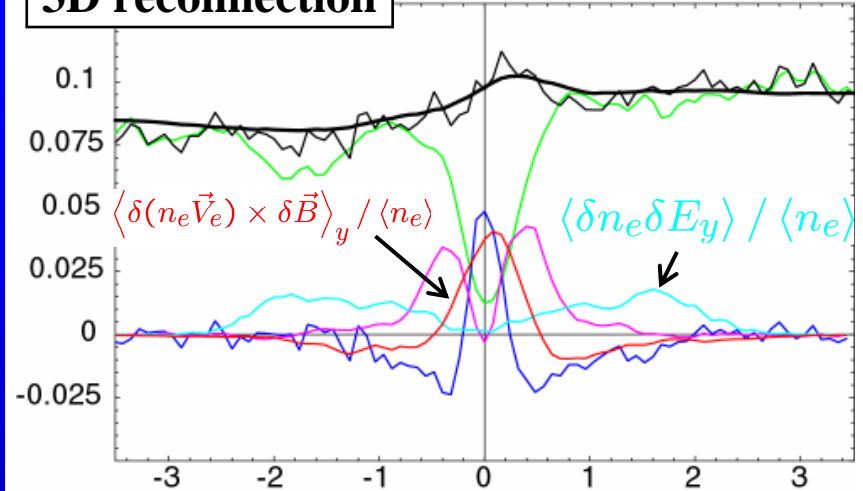
$$\begin{aligned} \langle -E_y \rangle &= \frac{1}{\langle n_e \rangle} \left( \langle n_e \vec{V}_e \rangle \times \langle \vec{B} \rangle \right)_y \\ &+ \frac{1}{e \langle n_e \rangle} \langle \nabla \cdot \vec{P}_e \rangle_y \\ &+ \frac{m_e}{e \langle n_e \rangle} \left\langle \frac{\partial V_{ey}}{\partial t} + \vec{V}_e \cdot \nabla V_{ey} \right\rangle \end{aligned}$$

$$\begin{aligned} &+ \frac{1}{\langle n_e \rangle} \langle \delta n_e \delta E_y \rangle \\ &+ \frac{1}{\langle n_e \rangle} \langle \delta(n_e \vec{V}_e) \times \delta \vec{B} \rangle_y \end{aligned}$$

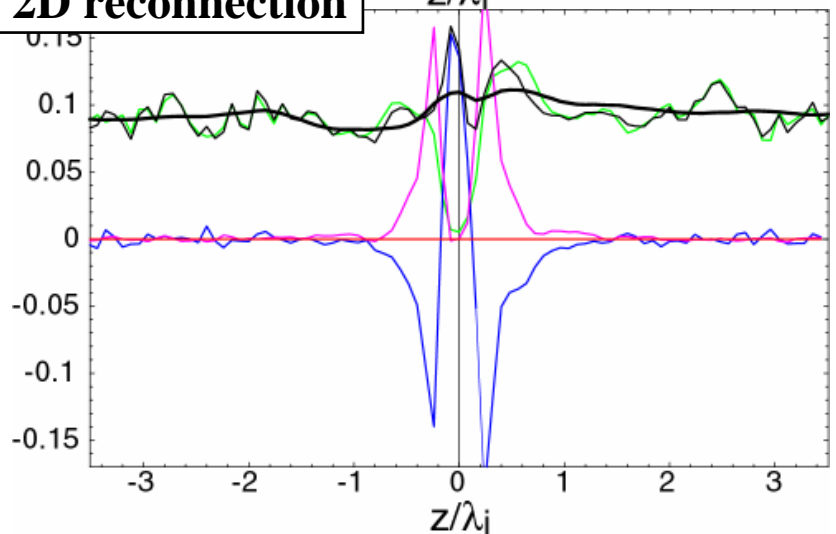
Anomalous effects



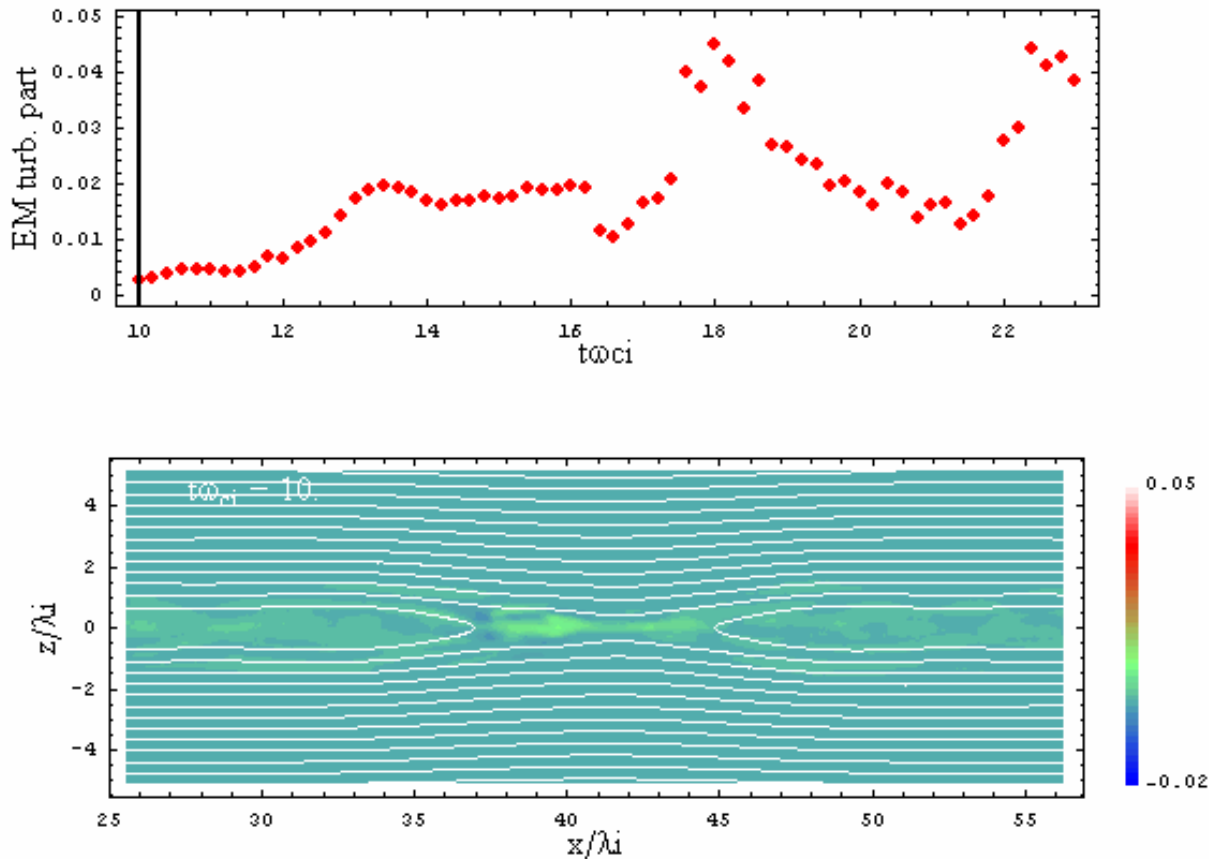
## 3D reconnection



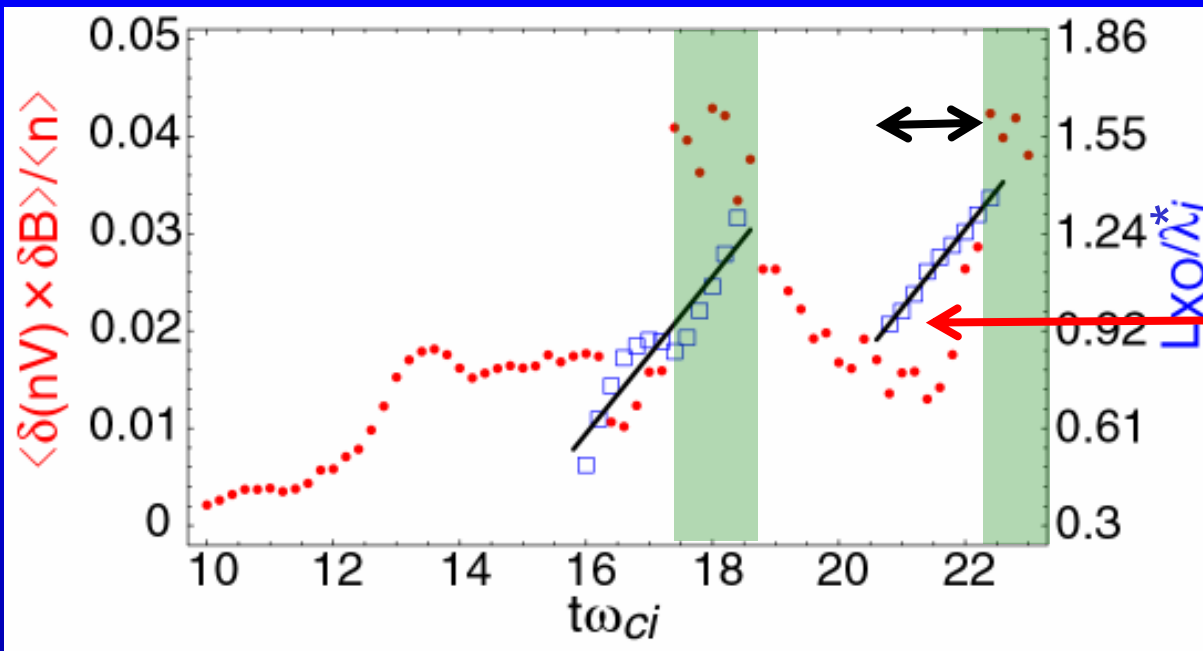
## 2D reconnection



# Anomalous Transport at the X-line

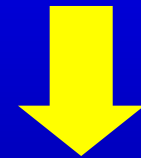


# Plasmoid-Induced Turbulence



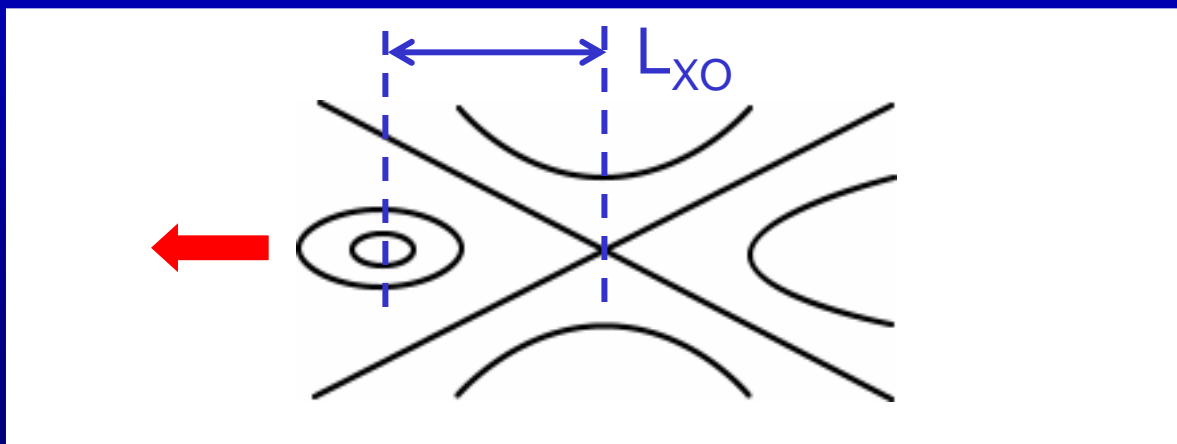
$$\Delta t = 1.6 \omega_{ci}^{-1}$$

$$L_{XO} = 0.95 \lambda_i^*$$

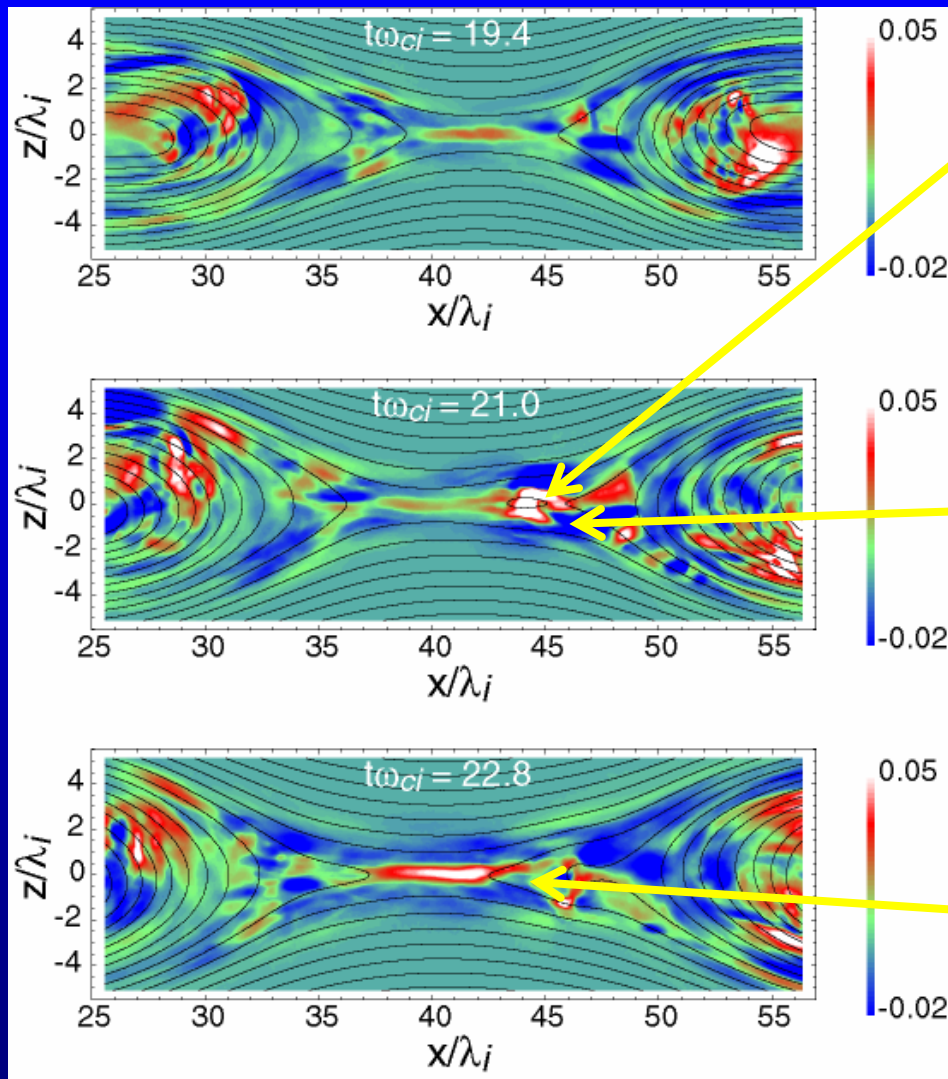


Information propagates at

$$V_p \sim V_A^* \\ (B^* = 0.5B_0)$$



# Plasmoid-Induced Turbulence



Plasmoid formation

Wave  
amplification

Local turbulence  
enhancement

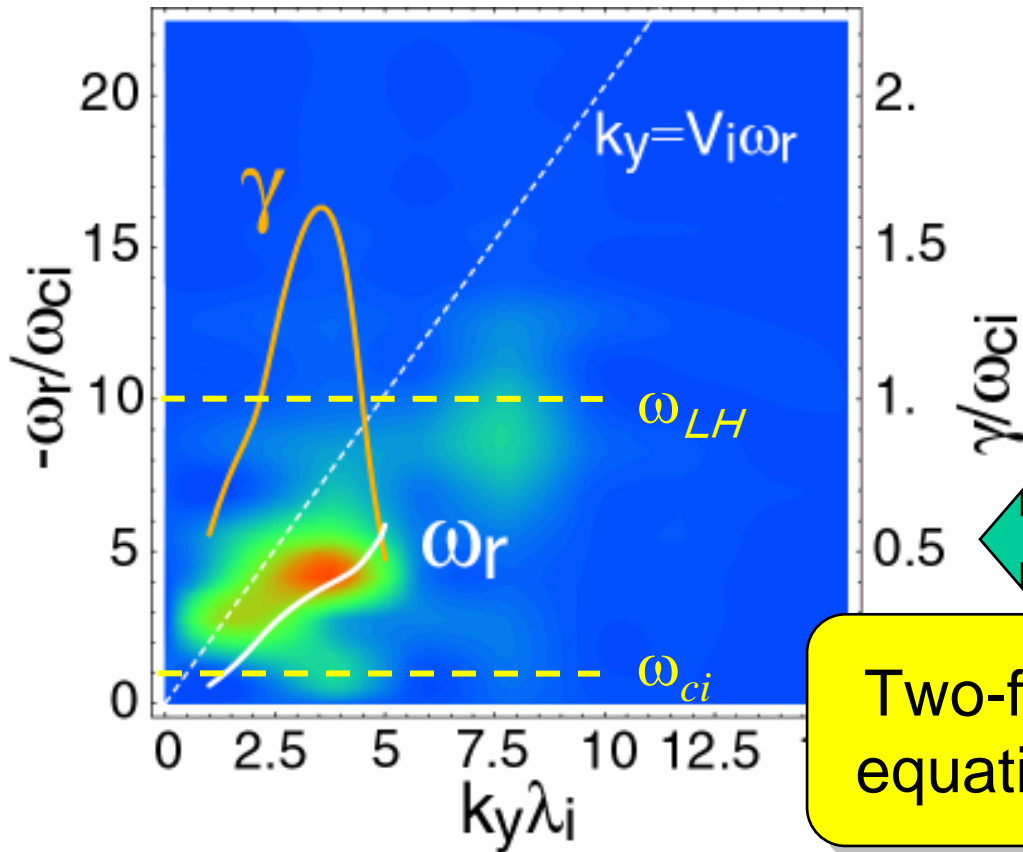
Propagation along  
the field line

Intensified turbulence  
at the x-line



# Wave Properties

$$\omega = \omega_r + i\gamma$$



Two-fluid equations

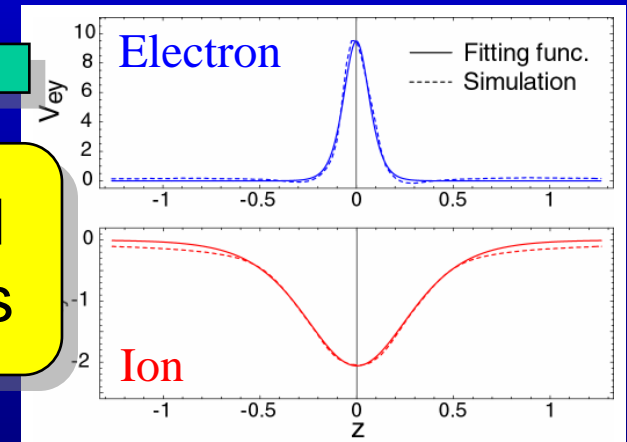
## Simulation results

$$\omega_{ci} < |\omega_r| < \omega_{LH}$$

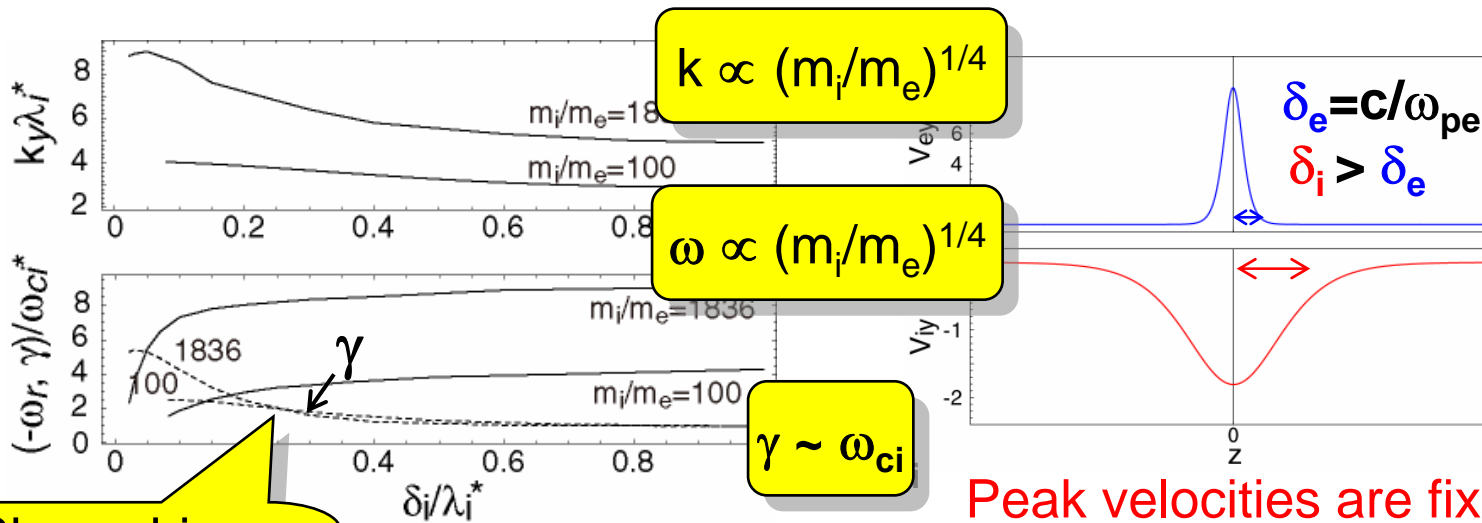
$$V_{ph} \approx V_A$$

## Linear analyses

Profiles taken from simulation



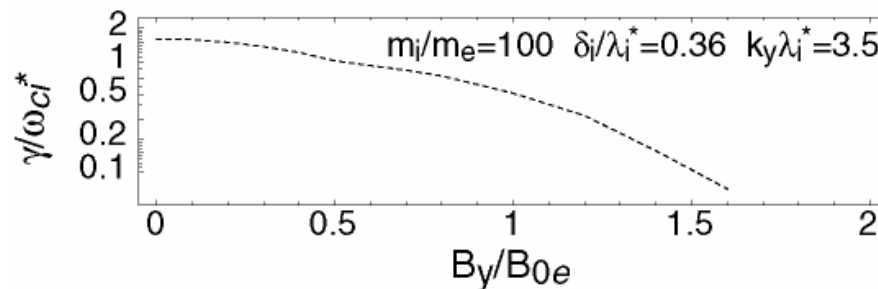
# Wave Properties: Linear Analyses



Shear driven mode rather than the drift mode

$$\gamma \propto \partial V_d / \partial z$$

The wave survives even for  $m_i/m_e = 1836$ .



Dependence on the guide field ( $B_y$ )

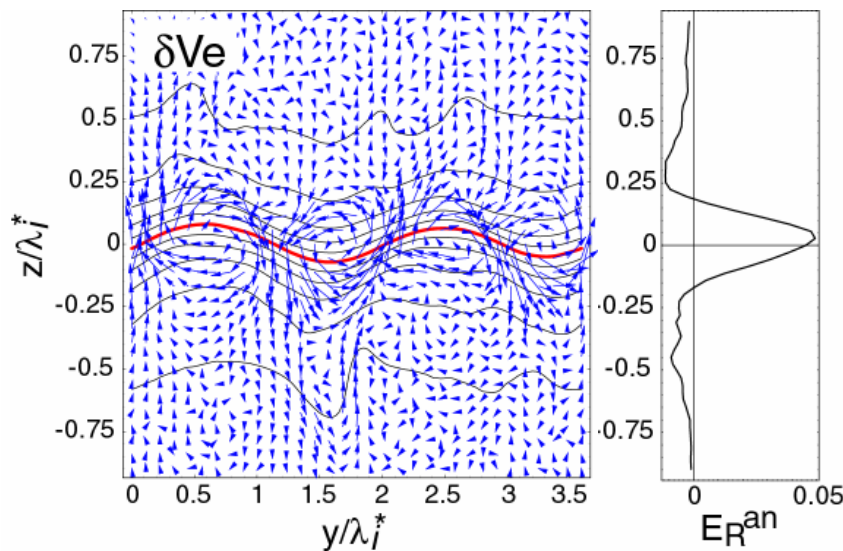
# 運動量の異常輸送

[Fujimoto & Sydora, in prep.]

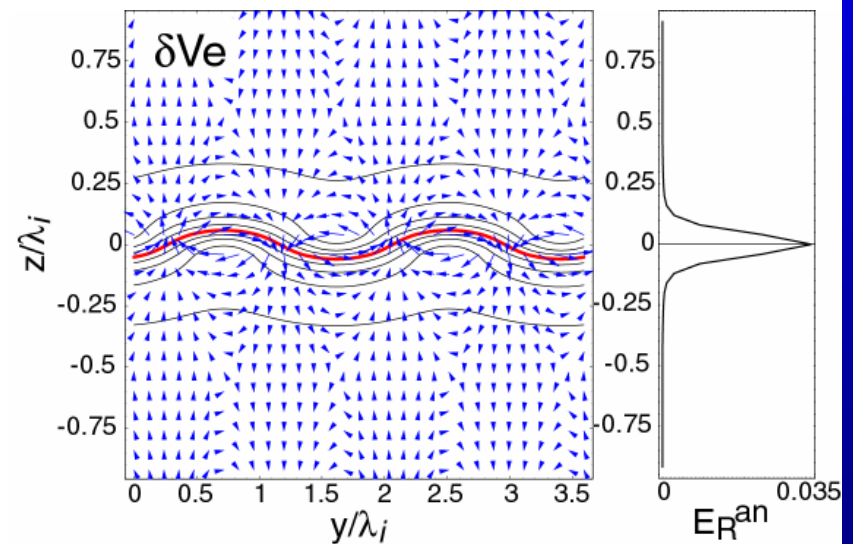
## 電磁波動による電子運動量の異常輸送

$$E_R^{an} = \frac{1}{\langle n_e \rangle} \langle \delta(n_e \vec{V}_e) \times \delta \vec{B} \rangle_y \quad \left( \langle \cdot \rangle = \frac{1}{L_y} \int_0^{L_y} \cdot dy \right)$$

### シミュレーション



### 線形理論



# Summary

大規模な3次元粒子シミュレーションを実施して、高速磁気リコネクション時における磁気拡散機構を調べた。

プラズモイドによって誘発される電磁的乱流が磁気拡散過程において重要な役割を果たすことがわかった。

線形波動解析を実施することによって、乱流を引き起こす電磁波動の特性を調べた。

- $\omega_{ci} < \omega_r < \omega_{LH}$
- シアー駆動型不安定性
- $m_i/m_e=1836$  でも大きな成長率

[Fujimoto & Sydora, PRL, 2012]

